

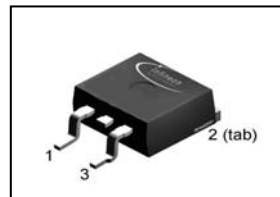
OptiMOS[®] -T Power-Transistor
Features

- N-channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- **Green package (lead free)**
- Ultra low R_{ds(on)}
- 100% Avalanche tested
- ESD Class 1C (HBM)
EIA/JESD22-A114-B

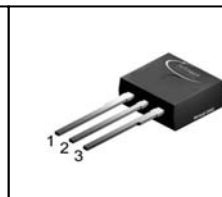
Product Summary

V_{DS}	55	V
$R_{DS(on),max}$ (SMD version)	24.8	mΩ
I_D	25	A

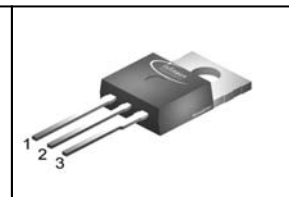
PG-TO263-3-2



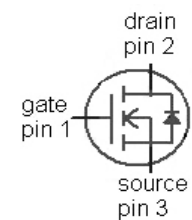
PG-TO262-3-1



PG-TO220-3-1



Type	Package	Ordering Code	Marking
IPB25N06S3-25	PG-TO263-3-2	SP0000-88000	3N0625
IPI25N06S3-25	PG-TO262-3-1	SP0000-87997	3N0625
IPP25N06S3-25	PG-TO220-3-1	SP0000-88001	3N0625


Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ¹⁾	I_D	$T_C=25\text{ °C}$, $V_{GS}=10\text{ V}$	25	A
		$T_C=100\text{ °C}$, $V_{GS}=10\text{ V}^{2)}$	23	
Pulsed drain current ²⁾	$I_{D,pulse}$	$T_C=25\text{ °C}$	100	
Avalanche energy, single pulse ³⁾	E_{AS}	$I_D=12\text{ A}$	60	mJ
Drain gate voltage ²⁾	V_{DG}		55	V
Gate source voltage ⁴⁾	V_{GS}		±20	V
Power dissipation	P_{tot}	$T_C=25\text{ °C}$	48	W
Operating and storage temperature	T_j, T_{stg}		-55 ... +175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics²⁾						
Thermal resistance, junction - case	R_{thJC}		-	-	3.3	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}		-	-	62	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ⁵⁾	-	-	40	

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified
Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=1\text{ mA}$	55	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=20\text{ }\mu\text{A}$	2.1	3.0	4.0	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=55\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ °C}$	-	-	1	μA
		$V_{DS}=55\text{ V}, V_{GS}=0\text{ V}, T_j=125\text{ °C}^{2)}$	-	1	100	
Gate-source leakage current	I_{GSS}	$V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}, I_D=15\text{ A}$	-	21.6	25.1	m Ω
		$V_{GS}=10\text{ V}, I_D=15\text{ A},$ SMD version	-	21.3	24.8	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics²⁾

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=25\text{ V},$ $f=1\text{ MHz}$	-	1862	-	pF
Output capacitance	C_{oss}		-	283	-	
Reverse transfer capacitance	C_{rss}		-	270	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=27.5\text{ V},$ $V_{GS}=10\text{ V}, I_D=25\text{ A},$ $R_G=14.8\ \Omega$	-	15	-	ns
Rise time	t_r		-	27	-	
Turn-off delay time	$t_{d(off)}$		-	16	-	
Fall time	t_f		-	27	-	

Gate Charge Characteristics²⁾

Gate to source charge	Q_{gs}	$V_{DD}=11\text{ V}, I_D=25\text{ A},$ $V_{GS}=0\text{ to }10\text{ V}$	-	14	-	nC
Gate to drain charge	Q_{gd}		-	6	-	
Gate charge total	Q_g		-	27	41	
Gate plateau voltage	$V_{plateau}$		-	7.0	-	V

Reverse Diode²⁾

Diode continuous forward current	I_S	$T_C=25\text{ }^\circ\text{C}$	-	-	25	A
Diode pulse current	$I_{S,pulse}$		-	-	100	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=25\text{ A},$ $T_J=25\text{ }^\circ\text{C}$	0.6	0.9	1.3	V
Reverse recovery time	t_{rr}	$V_R=27.5\text{ V}, I_F=I_S,$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	38		ns
Reverse recovery charge	Q_{rr}	$V_R=27.5\text{ V}, I_F=I_S,$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	30		nC

¹⁾ Current is limited by bondwire; with an $R_{thJC} = 3.3\text{ K/W}$ the chip is able to carry 30 A at 25°C. For detailed information see Application Note ANPS071E at www.infineon.com/optimos

²⁾ Defined by design. Not subject to production test.

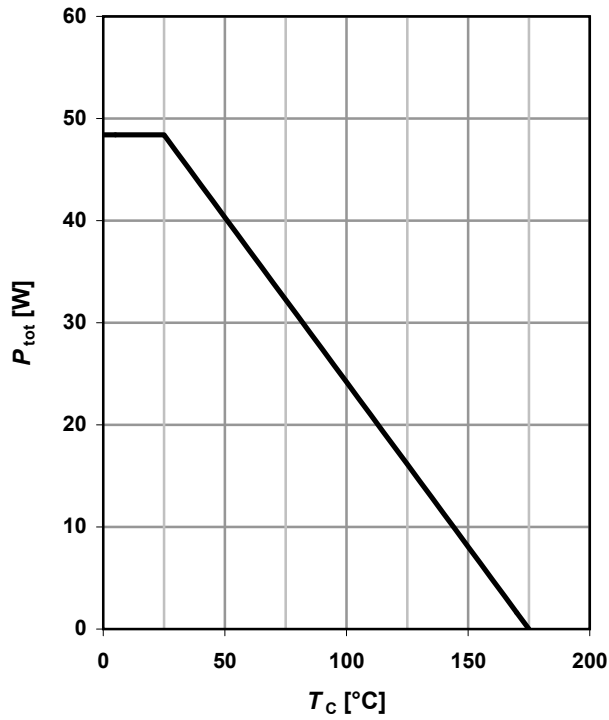
³⁾ See diagrams 12 and 13.

⁴⁾ Qualified at -5V and +20V.

⁵⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

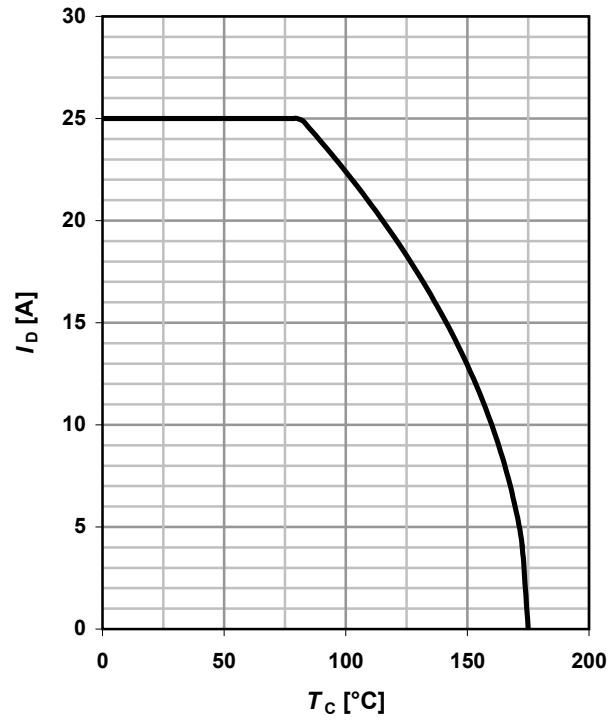
1 Power dissipation

$P_{tot} = f(T_C); V_{GS} \geq 6 V$



2 Drain current

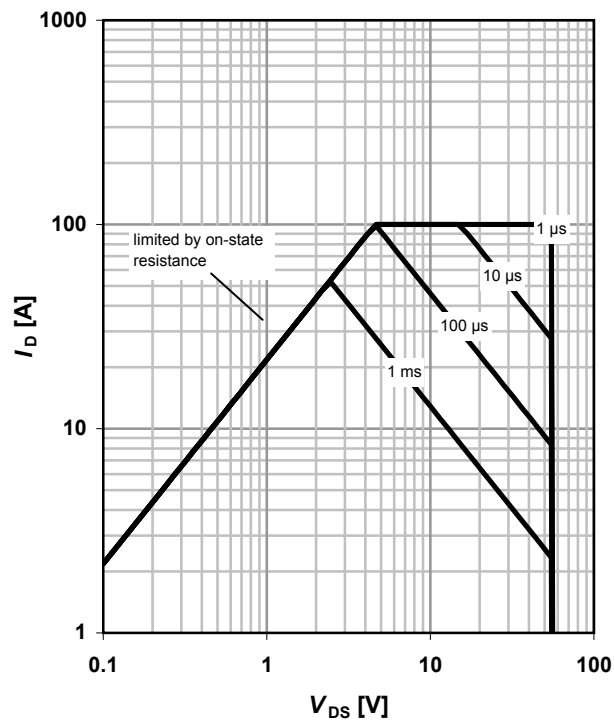
$I_D = f(T_C); V_{GS} \geq 6 V$



3 Safe operating area

$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$

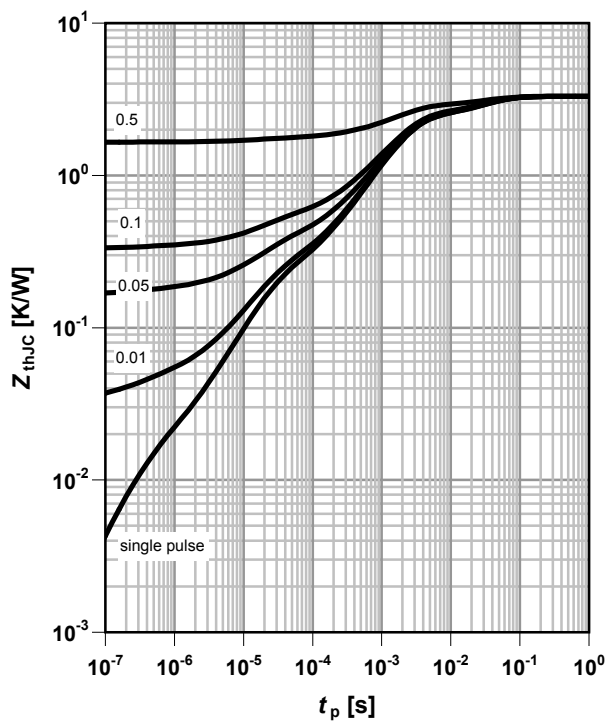
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJC} = f(t_p)$

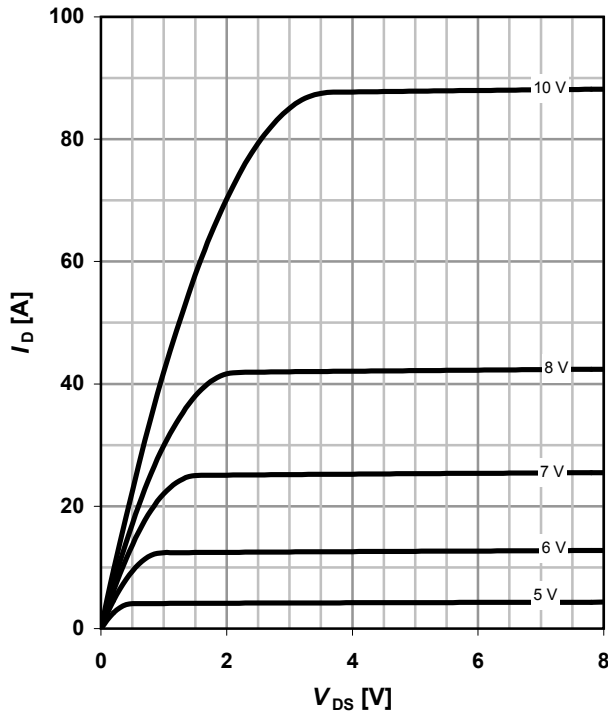
parameter: $D = t_p/T$



5 Typ. output characteristics

$I_D = f(V_{DS}); T_j = 25\text{ }^\circ\text{C}$

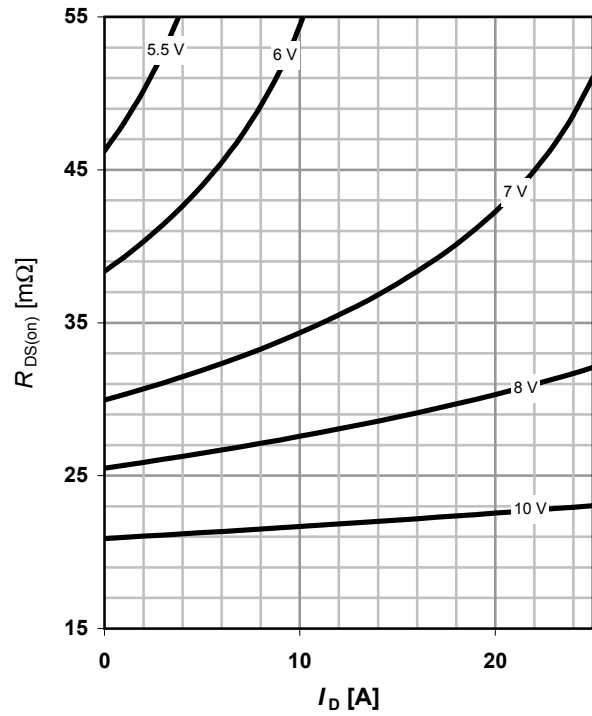
parameter: V_{GS}



6 Typ. drain-source on-state resistance

$R_{DS(on)} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

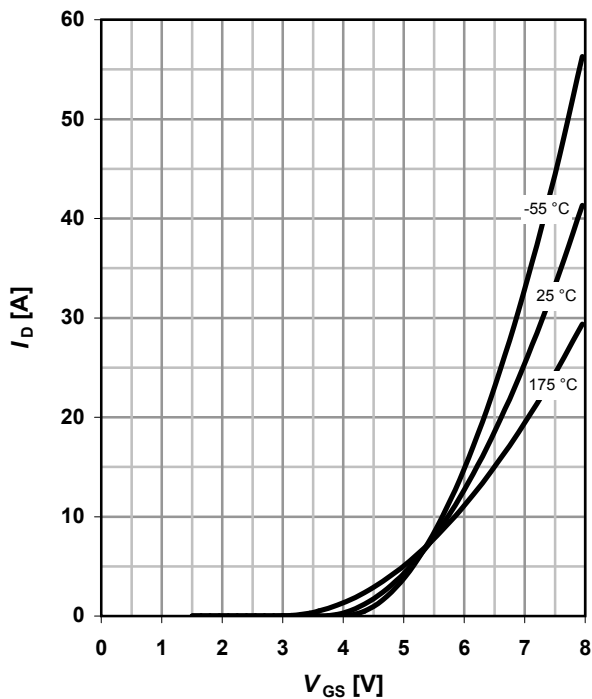
parameter: V_{GS}



7 Typ. transfer characteristics

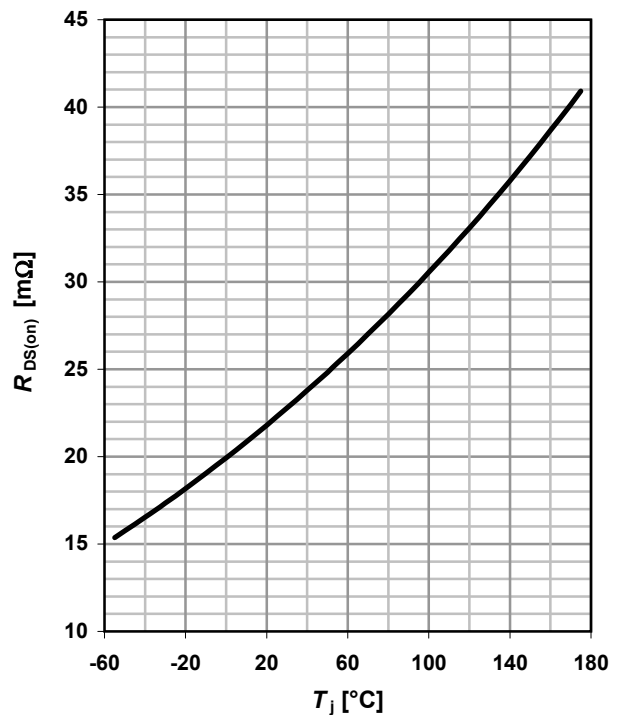
$I_D = f(V_{GS}); V_{DS} = 6\text{ V}$

parameter: T_j



8 Typ. drain-source on-state resistance

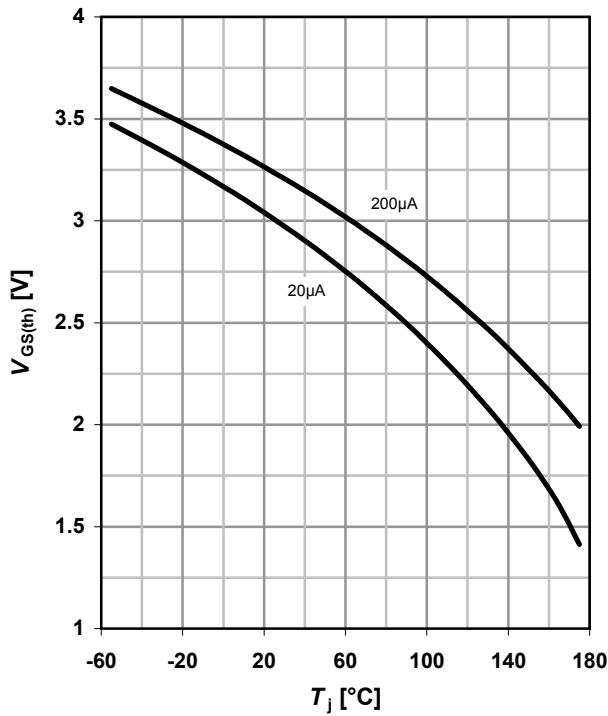
$R_{DS(on)} = f(T_j); I_D = 25\text{ A}; V_{GS} = 10\text{ V}$



9 Typ. gate threshold voltage

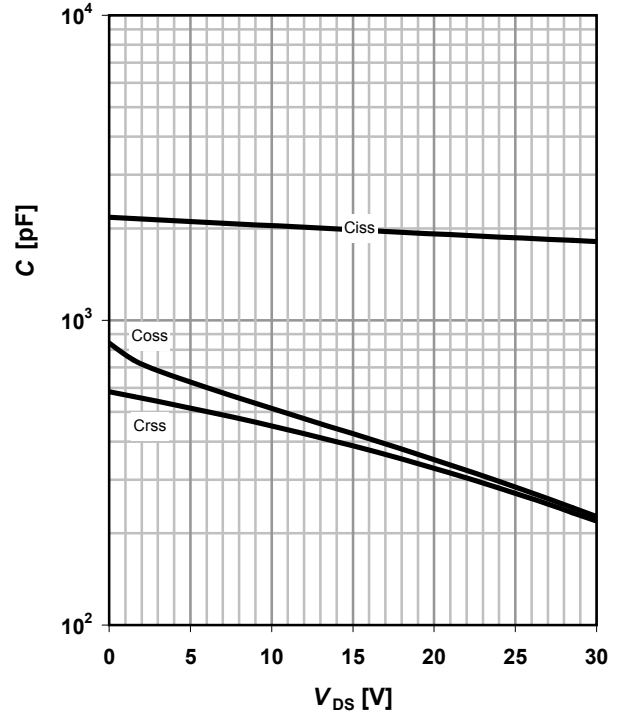
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D



10 Typ. capacitances

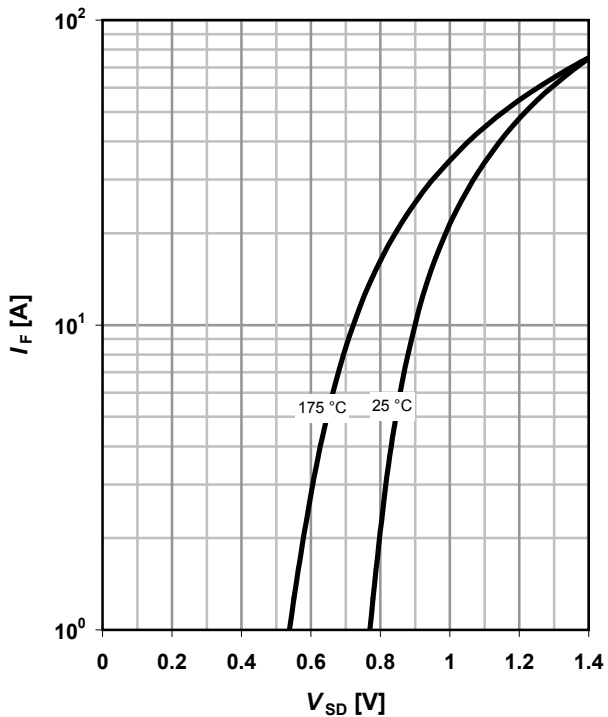
$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



11 Typical forward diode characteristics

$I_F = f(V_{SD})$

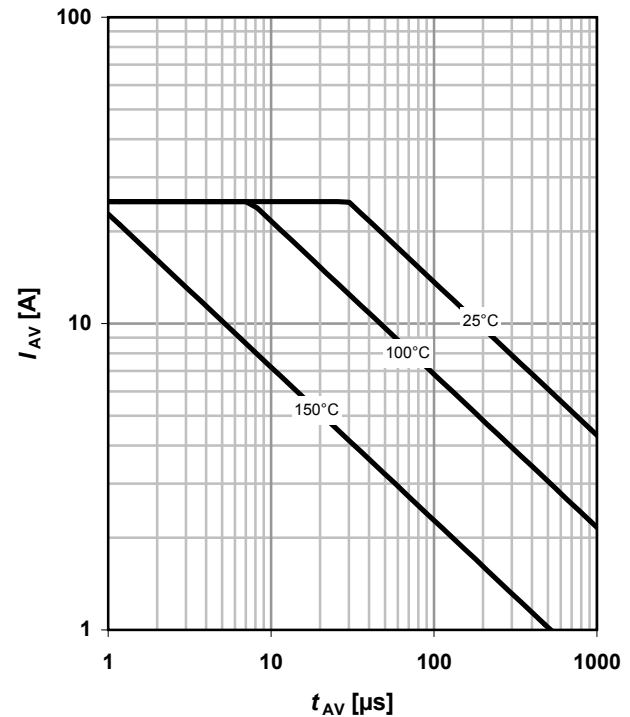
parameter: T_j



12 Typ. avalanche characteristics

$I_{AS} = f(t_{AV})$

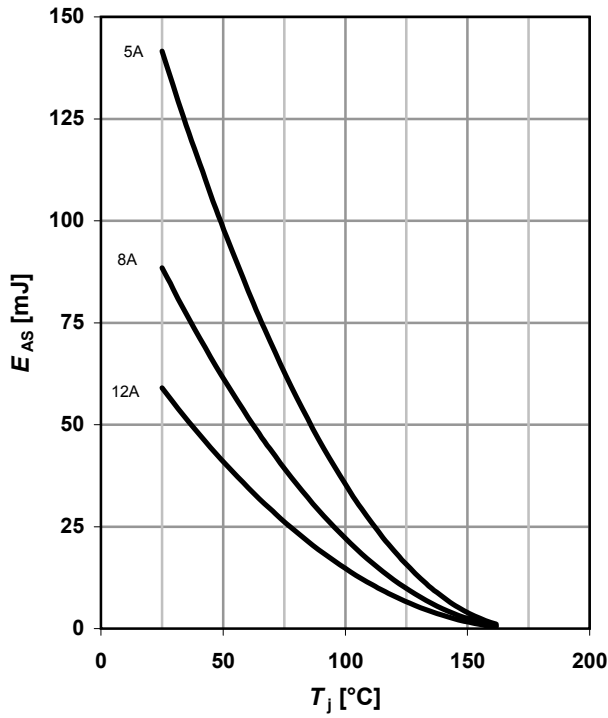
parameter: $T_{j(start)}$



13 Typical avalanche energy

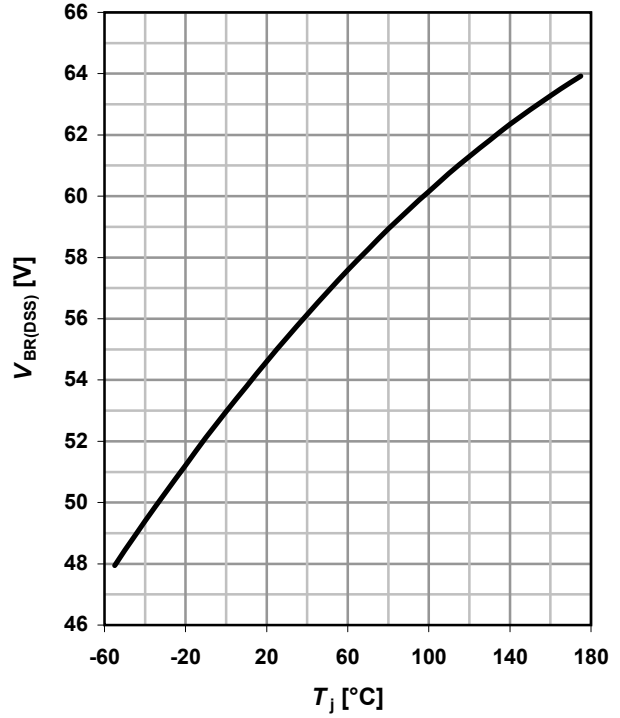
$$E_{AS} = f(T_j)$$

parameter: I_D



14 Typ. drain-source breakdown voltage

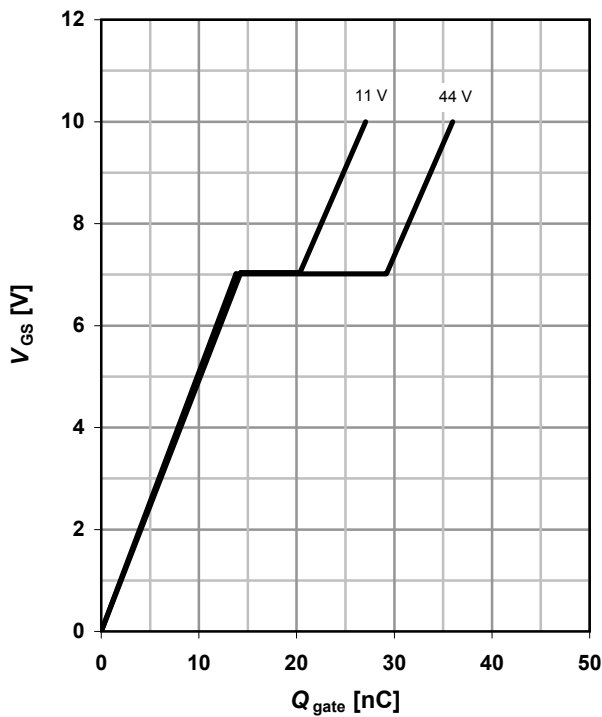
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



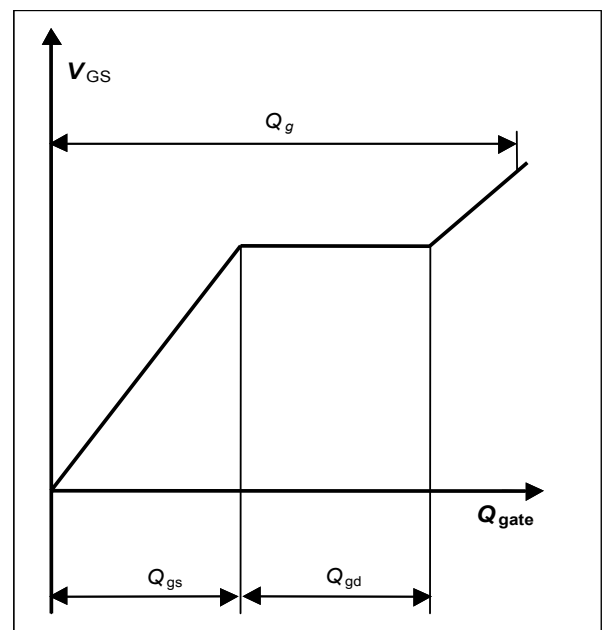
15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 25 \text{ A pulsed}$$

parameter: V_{DD}



16 Gate charge waveforms



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